

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

251774US2

SERIAL NO. 10/822007

~~NEW ABSTRACT~~

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hideaki SHIMODA

FILING DATE

~~NEW ABSTRACT~~ 4/12/2004

GROUP

2817

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<del>SA</del>	AO	2000-114801	04/21/00	Japan		X
<del>SA</del>	AP	2000-68715	03/03/00	Japan		X
<del>SA</del>	AQ	9-321507	12/12/97	Japan		X
<del>SA</del>	AR	9-321509	12/12/97	Japan (with English Abstract)		X
<del>SA</del>	AS	2001-308547	11/02/01	Japan (with English Abstract)		X
<del>SA</del>	AT	10-163713	06/19/98	Japan (with English Abstract)		X
<del>SA</del>	AU	9-172303	06/30/97	Japan (with English Abstract)		X
<del>SA</del>	AV	9-51208	02/18/97	Japan (with English Abstract)		X
<del>SA</del>	AW	6-21253	01/28/94	Japan (with English Abstract)		X

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

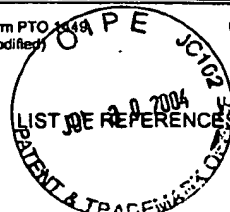
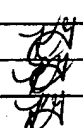

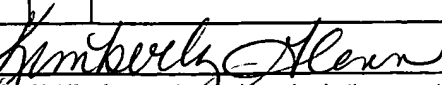
Examiner

*Kimberly Allen*

Date Considered

8/1/05

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1549 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 251774US2		SERIAL NO. 10/822,007	
				APPLICANT Hideaki SHIMODA			
				FILING DATE April 12, 2004		GROUP 2817	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
AA							
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<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	2000-68716	03/03/2000	JAPAN (with English Abstract)		X	
	AP	2 625 373	06/30/1989	FRANCE		X	
	AQ	0 358 497	03/14/1990	EUROPE			
	AR						
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW	J. KIM, et al., Electrical Performance of Electronic Packaging, IEEE 7 <sup>TH</sup> Topical Meeting, XP-010313751, pages 252-255, "NOVEL MICROSTRIP-TO-STRIPLINE TRANSITIONS FOR LEAKAGE SUPPRESSION IN MULTILAYER MICROWAVE CIRCUITS", October 26-28, 1998					
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner: 					Date Considered: 8/11/05		
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